



# Test item list

1. <i>Test item list</i> -----	2
2. <i>Temp./humidity power on/off Test</i> -----	3
3. <i>Temperature cycle operation test</i> -----	4
4. <i>High temperature storage test</i> -----	7
5. <i>Low temperature storage test</i> -----	8
6. <i>Humidity test</i> -----	9
7. <i>Cold start and hot start test</i> -----	10

Num	Item	Spec
1.	Mounting Chassis:	FWS-7600
	1. PCB / CPU	FWB-7600 A0.2 (BIOS: 0.4)
	2. North Bridge	Intel 3010
	3. South Bridge	ICH7R
	4. Memory	Transcend DDR2-ECC 1GB / Transcend E5108AGBG * 4
	5. CFD	PQI 32MB (for DOS mode Power on/off test)
	6. SATA HDD	HITACHI HDS721616PLA380 / 160GB
	7. Mini PCI VGA Card	mPCI-8750
	8. Test Software	Windows XP / Run PassMark Burn In Test 4.0 Pro
2.	Power Supply	FSP FSP065-A 19V 3.42A

**Test Date:** 04-15~16-2008

**Test Product:** FWB-7600 A0.2 (with mini PCI VGA Card)

**Test Site:** AAEON QA Internal Lab.

**Test Standard:** Reference IEC 68-2-30 Testing procedures  
Test Db: Damp Heat Test

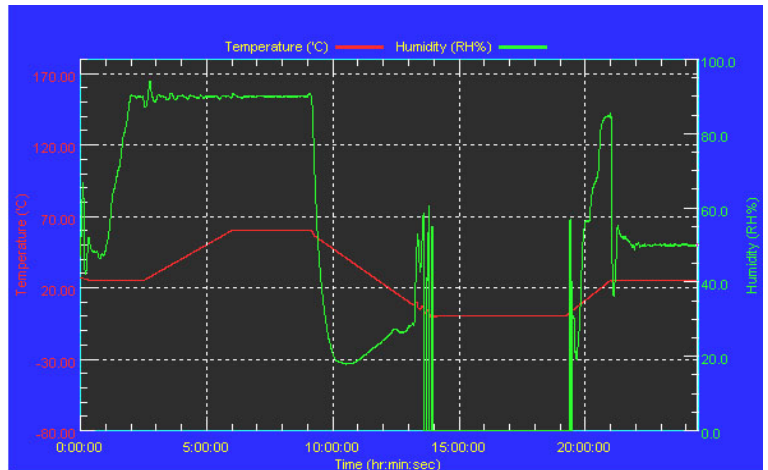
**Test Equipment:**  
Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.  
Model: THS-D7S-100+1 N2  
Date of Calibration: 12/13/07  
Serial Number: 3898

**Temperature & Humidity Power On/Off Test:**

**Testing Specification:**

Step	Temperature (°C)	Humidity (%RH)	Duration (HH:MM)
1	25	50	00:30
2	25	50	00:30
3	25	90	01:00
4	25	90	00:30
5	60	90	03:30
6	60	90	03:00
7	0	0	04:50
8	0	0	05:23
9	25	50	01:47
10	25	50	03:00

**Test Curve:**



**Sample Configuration & Quantity Under Test:**

Quantity: 1 (FWB-6700)

**Test Result:**

No problem was found during the temperature & humidity power on/off test.

]

# Temperature cycle test

**Test Date:** 11-02~05-2007

**Test Product:** FWS-7600 (with mini PCI VGA card)

**Test Site:** AAEON QA Internal Lab.

**Test Standard:** Reference IEC68-2-14 Testing procedures  
Test N: Change of temperature Test

**Test Equipment:**

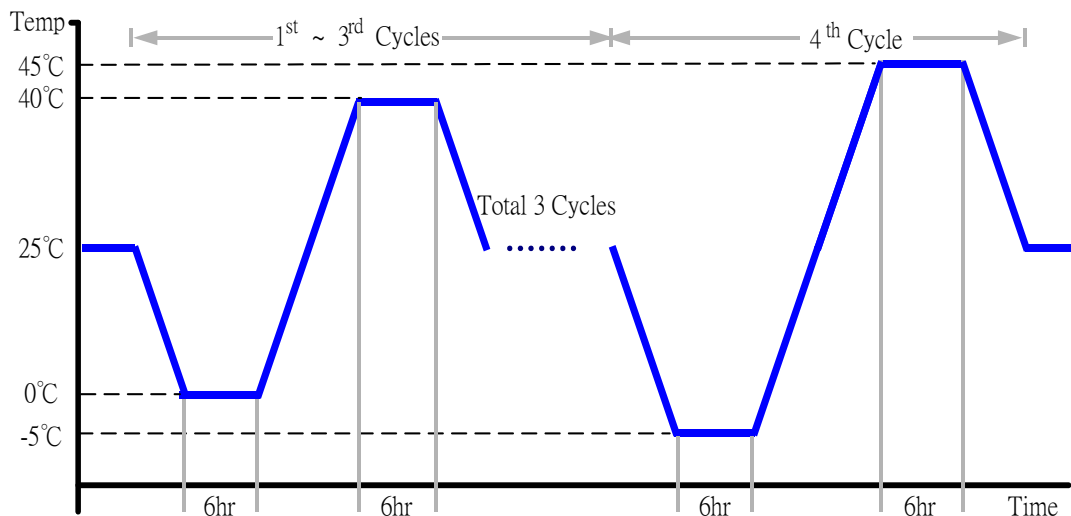
Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.  
Model: THS-D7S-100+1 N2  
Date of Calibration: 12/13/07  
Serial Number: 3898

**Temperature Measurement:**

40 Channel Thermal Recorder:  
YOKOGAWA Inc,  
Model: DA100-13-1D  
Date of Calibration: 12/13/07  
Serial Number: 12A323190

**Test Condition:**

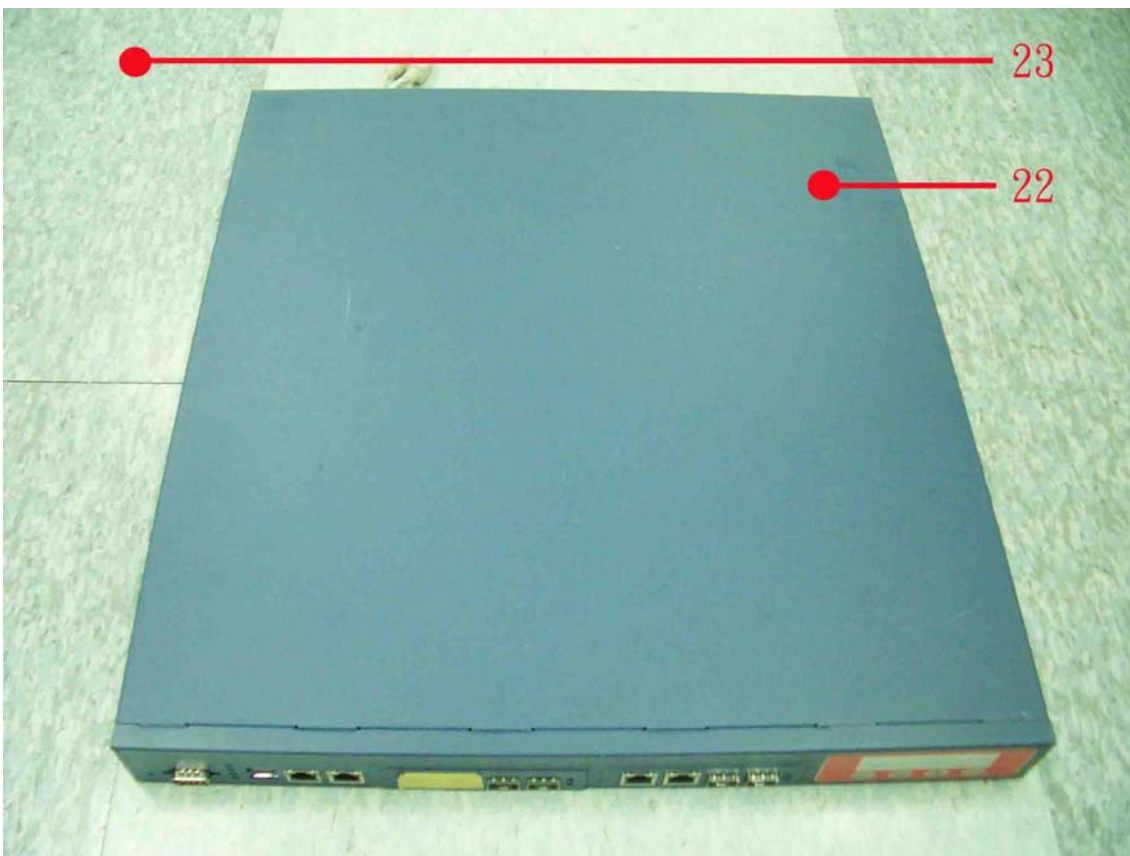
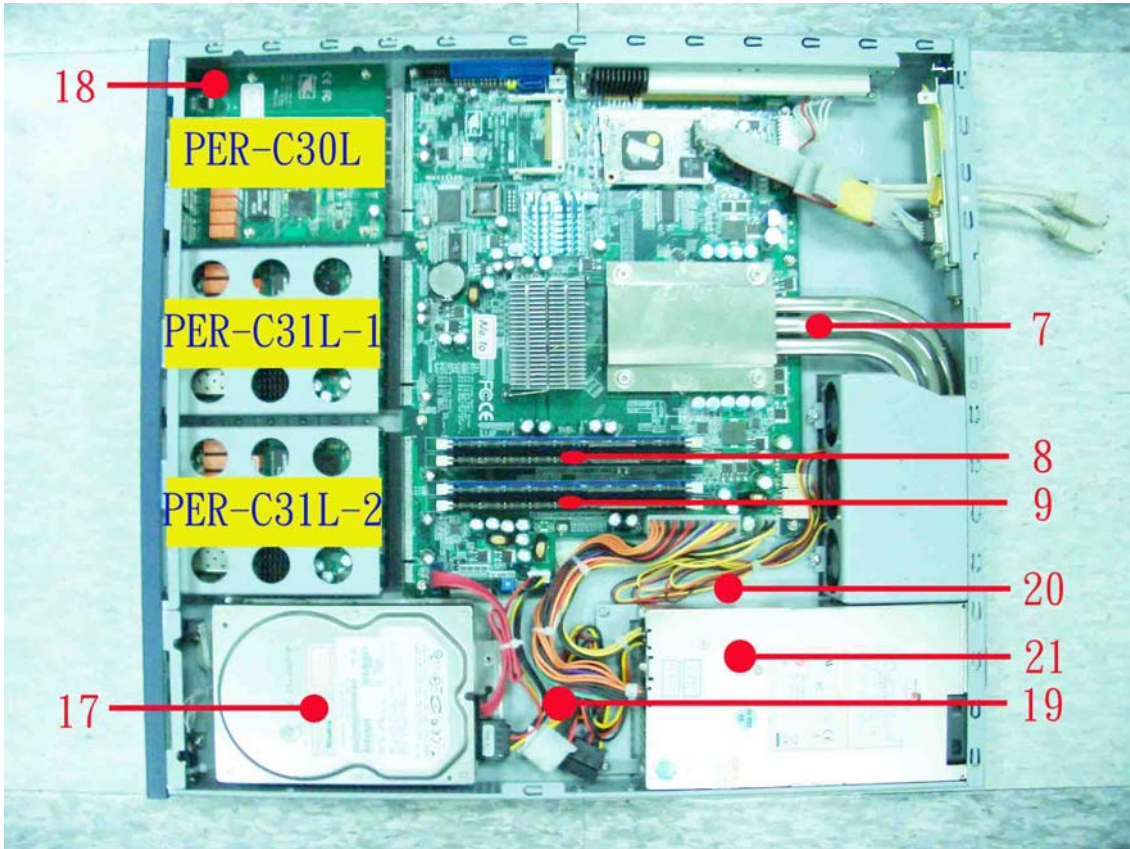
1. Test Low Temperature: 0°C (1~3 cycles)  
-5°C (4<sup>th</sup> cycle)
2. Test High Temperature: 40°C (1~3 cycles)  
45°C (4<sup>th</sup> cycle)
3. Test dwell time: 6Hrs
4. Temperature slope: 2°C/min
5. Test cycle: 4 cycles
6. Test Environment Curve:



# Temperature cycle test

## Temperature Recorder:

Measuring Thermal Couple Position :



# Temperature cycle test

## Thermal profile data:

### FWS-7600

Point	Temp. Stage(°C)	Spec	40	25	0
1. CPU: Intel Pentium 4 / 2.8GHz		70.8	68.4	53.4	28.4
2. U22 - (TF) Intel.QG3010 SL9Q6.		105	58.2	43.2	18.2
3. U21 - (TF) ICH7R.INTEL.NH82801GR SL8FY A1		99	60.7	45.7	20.7
4. U26 - (TF) ICS.ICS9DB108BFLF		115	61.0	46.0	21.0
5. L2 - (TF)COIL.GOTREND.GSTC133P-R68MF		125	74.3	59.3	34.3
6. L1 - (TF)COIL.GOTREND.GSTC133P-R68MF		125	73.9	58.9	33.9
7. Heat Pipe		N/A	62.4	47.4	22.4
8. Memory -1		70	50.5	35.5	10.5
9. Memory -2		70	49.4	34.4	9.4
10.U30 - (TF)MOSFET Drivers.INTERASIL.ISL6612ACBZ		110	58.2	43.2	18.2
11.U5 - (TF) GigaBit Ethernet Chipset.Intel.PC82573L (PER-C30L)		70	50.2	35.2	10.2
12.U2 - (TF) GigaBit Ethernet Chipset.Intel.PC82573L (PER-C30L)		70	47.9	32.9	7.9
13.U4 - (TF) GigaBit Ethernet Chipset.Intel.PC82573L (PER-C31L-1)		70	52.7	37.7	12.7
14.U3 - (TF) GigaBit Ethernet Chipset.Intel.PC82573L (PER-C31L-1)		70	54.8	39.8	14.8
15.U4 - (TF) GigaBit Ethernet Chipset.Intel.PC82573L (PER-C31L-2)		70	50.5	35.5	10.5
16.U3 - (TF) GigaBit Ethernet Chipset.Intel.PC82573L (PER-C31L-2)		70	48.4	33.4	8.4
17. HDD		55	44.7	29.7	4.7
18. Control Box Internal Air Temperature - 1		N/A	42.6	27.6	2.6
19. Control Box Internal Air Temperature - 2		N/A	43.2	28.2	3.2
20. Control Box Internal Air Temperature - 3		N/A	43.9	28.9	3.9
21.Power Supply		50	44.1	29.1	4.1
22.Control Box External Surface		N/A	47.0	32.0	7.0
23.Chamber Air Temperature		N/A	40.9	25.9	0.9

## Sample Configuration & Quantity Under Test:

Quantity: 1 (FWS-7600)

## Test Result:

No problem was found during the temperature cycle operation test.

# High temperature storage test

**Test Date:** 04-07~09-2008

**Test Product:** FWS-7600 (with mini PCI VGA card)

**Test Site:** AAEON QA Internal Lab.

**Test Standard:** Reference IEC 68-2-2 Testing procedures  
Test Bb: Dry Heat Test (Non-operation)

**Test Equipment:**

Programmable Temperature & Humidity Chamber

K.SON. INS. TECH. CORP.

Model: THS-D7S-100+1 N2

Date of Calibration: 12/13/07

Serial Number: 3898

**Testing Item:**

1. Test Temperature: 60°C
2. Test Times: 48Hrs
3. Test Software: Windows XP / Run PassMark Burn In Test 4.0 Pro
4. Test Environment Curve:



**Sample Configuration & Quantity Under Test:**

Quantity: 1 (FWS-7600)

**Test Result:**

No problem was found after the high temperature storage test.

**Test Date:** 04-09~11-2008

**Test Product:** FWS-7600 (with mini PCI VGA card)

**Test Site:** AAEON QA Internal Lab.

**Test Standard:** Reference IEC 68-2-1  
Testing procedures Test Ab: Cold Test (Non-operation)

**Test Equipment:**

Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.

Model: THS-D7S-100+1 N2

Date of Calibration: 12/13/07

Serial Number: 3898

**Testing Item:**

1. Test Temperature: -20°C
2. Test Times: 48Hrs
3. Test Software: Windows XP / Run PassMark Burn In Test 4.0 Pro
4. Test Environment Curve:



**Sample Configuration & Quantity Under Test:**

Quantity: 1 (FWS-7600)

**Test Result:**

No problem was found after the low temperature storage test.



**Test Date:** 04-11~14-2008

**Test Product:** FWS-7600 (with mini PCI VGA card)

**Test Site:** AAEON QA Internal Lab.

**Test Standard:** Reference IEC 68-2-3 Testing procedures  
Test Ca: Damp heat, steady state (Non-operation)

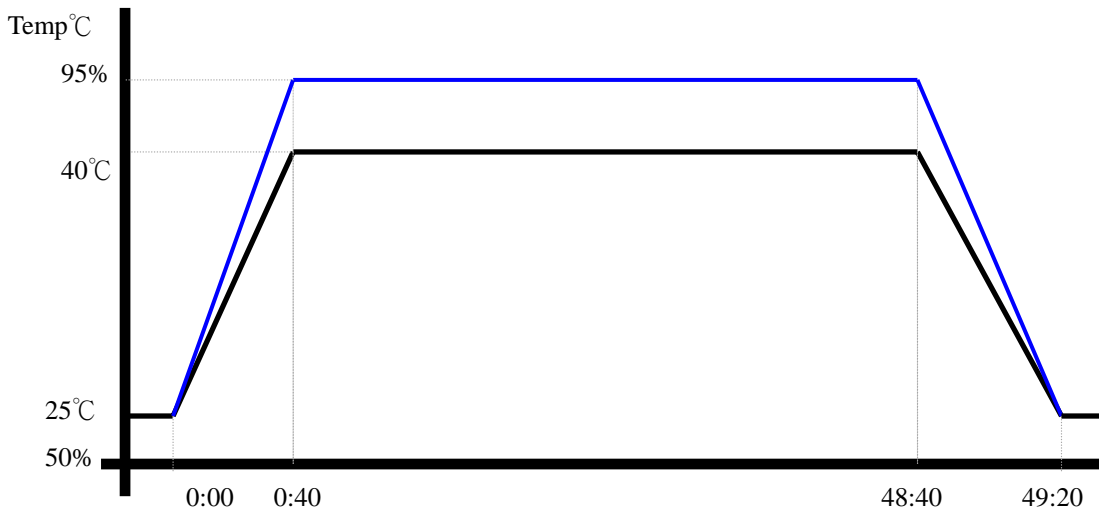
**Test Equipment:**

Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.  
Model: THS-D7S-100+1 N2  
Date of Calibration: 12/13/07  
Serial Number: 3898

**Testing Item:**

1. Test Temperature: 40°C
2. Test Humidity: 95%RH
3. Test Times: 48Hrs
4. Test Software: Windows XP / Run PassMark Burn In Test 4.0 Pro
5. Test Environment Curve:

**Humidity %**



**Sample Configuration & Quantity Under Test:**

Quantity: 1 (FWS-7600)

**Test Result:**

No problem was found after the humidity test.

# Cold start and hot start test

**Test Date:** 04-16~17-2008

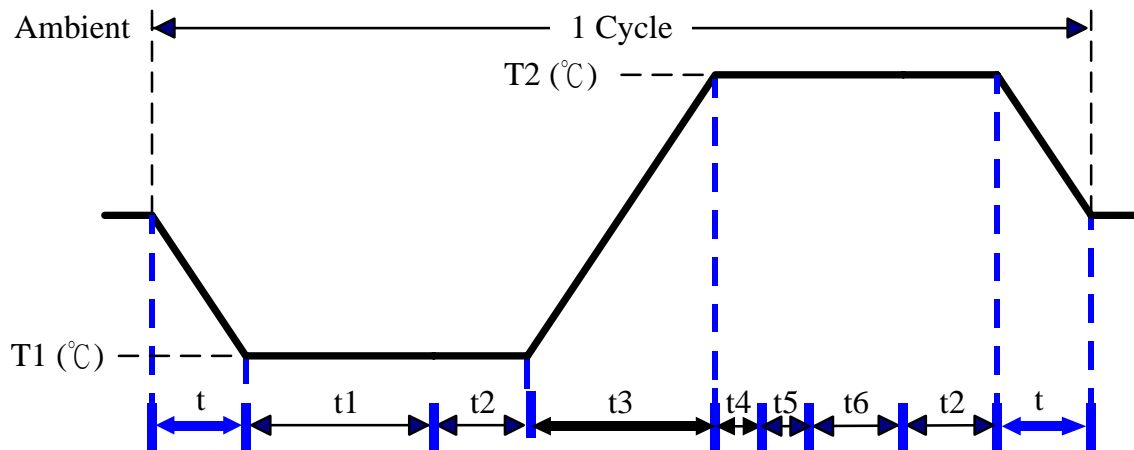
**Test Site:** AAEON QA Internal Lab.

**Test Product:** FWS-7600 (with mini PCI VGA card)

**Test Standard:** Reference IEC 68-2-14 Testing procedures  
Test N: Change of temperature Test

**Test Equipment:**  
Programmable Temperature & Humidity Chamber  
K.SON. INS. TECH. CORP.  
Model: THS-D7S-100+1 N2  
Date of Calibration: 12/13/07  
Serial Number: 3898

**Test Condition:**



Parameters	Description
T1	-5°C
T2	45°C
t1	4 hrs
t2, t6	2 hrs
t4, t5	1hrs
t, t3	2°C/min
n (Cycle)	1

t = temprature slope  
t, t1, t6: Power Off  
t2: Power on/off test 10 times (on 2 min / off 5min)  
t3, t4: Run PassMark Burn In Test  
t5: Win XP Software restart test 3 times  
Test Software: Windows XP

**Test Result:**

- a. No problem was found during the cold start test.
- b. No problem was found during the hot start test.